

Notice of References Cited	Application/Control No. 10/525,739	Applicant(s)/Patent Under Reexamination EBIKO, KEISUKE	
	Examiner Leon Flores	Art Unit 2611	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,822,323 A	10-1998	Kaneko et al.	370/480
*	B	US-2002/0181489 A1	12-2002	Kitagawa et al.	370/441
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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